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- EPIC™ (Enhanced-Performance Implanted CMOS) Process
- Typical V_{OLP} (Output Ground Bounce)
 < 0.8 V at V_{CC}, T_A = 25°C
- Typical V_{OHV} (Output V_{OH} Undershoot)
 2 V at V_{CC}, T_A = 25°C
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (D, NS), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Flat (W) Packages, Chip Carriers (FK), and 300-mil DIPs (J)

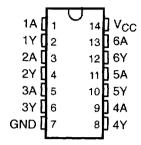
description

These hex inverters are designed for 2-V to 5.5-V V_{CC} operation.

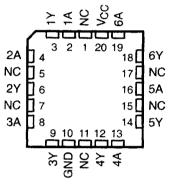
The 'LV04A devices contain six independent inverters. These devices perform the Boolean function $Y = \overline{A}$.

The SN54LV04A is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74LV04A is characterized for operation from -40°C to 85°C.

SN54LV04A . . . J OR W PACKAGE SN74LV04A . . . D, DB, NS, OR PW PACKAGE (TOP VIEW)



SN54LV04A ... FK PACKAGE (TOP VIEW)



NC - No internal connection

FUNCTION TABLE (each inverter)

INPUT A	OUTPUT Y
Н	L
L	Н



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

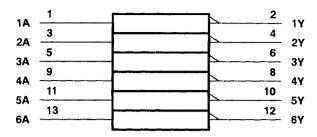
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SN54LV04A, SN74LV04A HEX INVERTERS

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logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, J, NS, PW, and W packages.

logic diagram, each inverter (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}		0.5 V to 7 V
Input voltage range, V _I (see Note 1)		0.5 V to 7 V
Output voltage range, VO (see Notes 1 and 2)		\cdot . -0.5 V to V _{CC} + 0.5 V
Input clamp current, $I_{ K }(V_{ } < 0)$		20 mA
Output clamp current, IOK (VO < 0 or VO > VCO	D)	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})		±25 mA
Continuous current through V _{CC} or GND	. <i>,</i> , , , , , , , , , , , , , , ,	±50 mA
Package thermal impedance, θ _{JA} (see Note 3):	: D package	127°C/W
	DB package	158°C/W
	NS package	127°C/W
	PW package	170°C/W
Storage temperature range, T _{stg}		–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. This value is limited to 7 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51.



recommended operating conditions (see Note 4)

			SN54I	SN54LV04A		LV04A	
			MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage		2	5.5	2	5.5	V
		V _{CC} = 2 V	1.5		1.5		
VIH	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	V _{CC} ×0.7		V _{CC} ×0.7] ,,
VIH.	i ligi rievei li iput voitage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	V _{CC} ×0.7		V _{CC} ×0.7		٧
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	V _{CC} ×0.7		V _{CC} ×0.7		
		V _{CC} = 2 V		0.5		0.5	
VIL	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		V _{CC} ×0.3		V _{CC} ×0.3	\ _{\v}
VIL.	cow-iever input voltage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		V _{CC} ×0.3		V _{CC} ×0.3]
		V _{CC} = 4.5 V to 5.5 V		V ÇC ×0.3		V _{CC} ×0.3	
VI	Input voltage		0	<i>ુ</i> 5.5	0	5.5	V
٧o	Output voltage		0	Vcc	0	Vcc	V
		V _{CC} = 2 V	\$	-50		-50	μА
lou	High-level output current	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		2		-2	
ЮН	riigii-ievei oatput carrent	$V_{CC} = 3 V \text{ to } 3.6 V$	5	-6		-6	mA
		V _{CC} = 4.5 V to 5.5 V		-12		-12]
		V _{CC} = 2 V		50		50	μА
la.	Low-level output current	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		2		2	
IOL	cow-level output current	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		6		6	mA
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		12		12	
		V _{CC} = 2.3 V to 2.7 V	0	200	0	200	
Δt/Δν	Input transition rise or fall rate	V _{CC} = 3 V to 3.6 V	0	100	0	100	ns/V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	0	20	0	20	
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN5	4LV04/	4	SN	A	UNIT	
PARAMETER	1231 CONDITIONS	Vcc	MiN	TYP	MAX	MIN	TYP	MAX	UNIT
	IOH = -50 μA	2 V to 5.5 V	VCC-0.1			V _{CC} -0.1			
) Vari	IOH = -2 mA	2.3 V	2			2			v
∨он	IOH = -6 mA	3 V	2.48			2.48			v
	IOH = -12 mA	4.5 V	3.8			3.8			
	IOL = 50 μA	2 V to 5.5 V			0.1			0.1	
Vo.	I _{OL} = 2 mA	2.3 V		Æ	0.4			0.4	v
VOL	IOL = 6 mA	3 V		Ana	0.44			0.44	•
	I _{OL} = 12 mA	4.5 V	8	3	0.55			0.55	
11	V _I = V _{CC} or GND	5.5 V	Q		±1			±1	μА
lcc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V	- 3		20			20	μΑ
loff	V_1 or $V_0 = 0$ to 5.5 V	0 V		_	5			5	μΑ
0.	VI = VCC or GND	3.3 V		2.3			2.3		pF
Ci		5 V		2.3			2.3		pr

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switching characteristics over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T,	4 = 25°C	:	SN54LVQ4A	SN74L	V04A	
PANAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN MAX	MIN	MAX	UNIT
^t pd*	Α	Y	C _L = 15 pF		7.1	11.7	্ৰা ু	1	14	ns
^t pd	Α	Υ	C _L = 50 pF		10	15.5	^२ ्भ 18	1	18	ns

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T,	գ = 25°C	;	SN54LV04	1	SN74L	V04A	UNIT
PAMAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN. MA	x	MIN	MAX	UNI
^t pd*	Α	Υ	CL = 15 pF		5.1	7.1	<i>_</i> ∂_\` 8	.5	1	8.5	ns
^t pd	Α	Υ	C _L = 50 pF		7.3	10.6	₹24	12	1	12	ns

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	TO LOAD		= 25°C	;	SN54LVQ4A	SN74L	V04A	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	XAM NIM	MIN	MAX	UNIT	
^t pd*	Α	Υ	CL = 15 pF		3.6	5.5		1	6.5	ns	
t _{pd}	Α	Υ	CL = 50 pF		5.1	7.5	8.5	1	8.5	ns	

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.

noise characteristics, $V_{CC} = 3.3 \text{ V}$, $C_L = 50 \text{ pF}$, $T_A = 25^{\circ}\text{C}$ (see Note 5)

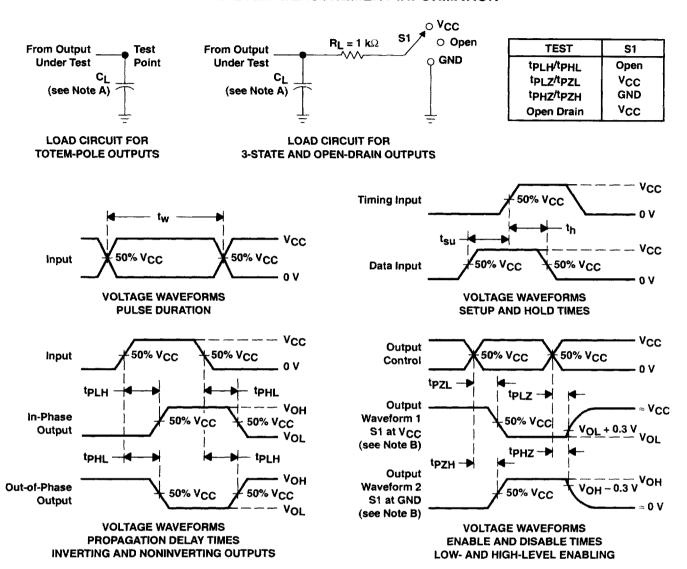
	DADASSTEP	SN74LV04A				
	PARAMETER	MIN	TYP	MAX	UNIT	
VOL(P)	Quiet output, maximum dynamic V _{OL}		0.26	0.8	V	
VOL(V)	Quiet output, minimum dynamic VOL		-0.01	-0.8	V	
VOH(V)	Quiet output, minimum dynamic V _{OH}		3.1		V	
V _{IH(D)}	High-level dynamic input voltage	2.31			V	
V _{IL(D)}	Low-level dynamic input voltage			0.99	٧	

NOTE 5: Characteristics are for surface-mount packages only.

operating characteristics, T_A = 25°C

	PARAMETER		TEST CONDITIONS			UNIT
	Deven dissipation consoltance	C 50 pE	f = 10 MHz	3.3 V	9.6	ρF
C _{pd}	Power dissipation capacitance	$C_L = 50 \text{ pF},$	1 = 10 WIC12	5 V	11.4	pr-

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_Q = 50 \Omega$, $t_f \leq$ 3 ns. $t_f \leq$ 3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpl z and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten-
- G. tpHL and tpLH are the same as tod.

Figure 1. Load Circuit and Voltage Waveforms

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